## Applicant(s)/Patent Under Reexamination UHDE ET AL. Application/Control No. 09/898,150 Notice of References Cited Examiner Art Unit Page 1 of 1 Jorge L. Ortiz-Criado 2627

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			,
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